

**Search Notes**

Application/Control No.

09/821,701

Examiner

John D. Lee

Applicant(s)/Patent under  
Reexamination

CHOU ET AL.

Art Unit

2874

**SEARCHED**

Class	Subclass	Date	Examiner
359	326-332	8/11/2005	JDL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
359	326-332	8/11/2005	JDL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Previous USPTO "WEST" Database search updated (same search terms)	8/11/2005	JDL
Interference search strategy on separate sheet	8/11/2005	JDL